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| 4 | Chen Chao Wang | Fan-out Chip on Substrate (FOCoS) Development for HPC and AI applications | Advanced Packaging | ACCEPT |
| 7 | Kui Li, Zihang Yuan, Chao Zhao, Yanmei Kong, Ruiwen Liu, Binbin Jiao and Gao Wu | A Low-Thermal-Resistance Packaging Technology in multi-chip Microsystem | Quality & Reliability | ACCEPT |
| 8 | Wentao Dou, Jw Seah, Vk Leong, Jingwei Sun, Bin Zhou, Lizhi Chen, Shijian Zhou, Qingnan Shi, Teng teng He and Feng Zhang | Revolutionizing Wafer-Level Chip-Scale Packaging: Advanced Die Chipping Solutions Using Laser Grooving and Plasma Dicing | Advanced Packaging | ACCEPT |
| 9 | Lois Liao, Zuohua Yu, Guoshun Wu, Xi Zhang, Lei Zhu, Younan Hua and Xiaomin Li | Comparison of moisture penetration speed in two types of SOP | Quality & Reliability | ACCEPT |
| 11 | Hanshi Wang, Shaogang Wang, Ke Liu, Huaiyu Ye and Chunjian Tan | Improvement on the short-circuit Performance of SiC MOSFET with different shapes and materials of the dielectric layer | Power Electronics | ACCEPT |
| 12 | Younan Hua, Lois Jinzhi and Xiaomin Li | Studies of Silicon Crystalline Defects Delineation Method and Application in Failure Analysis | Quality & Reliability | ACCEPT |
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| 18 | 一鸣 郝, 思 陈, 飞 秦 and 潮 李 | EVOLUTION ANALYSIS OF RESIDUAL STRESS IN CU-SIO2 HYBRID BONDING DURING BONDING PROCESS | Quality & Reliability | ACCEPT |
| 19 | Fa-Chuan Chen, Chien-Min Lin, Yin-Fa Chen, Bo-Kuan Yeh, Hsin-Long Chen, Yu-Hsing Lin, Che-Kuan Chu, Tai-Yin Lin and Zhe-Cheng Xu | Investigation of Polyimide Cracking Effects in Wafer-Level Chip Scale Package on Substrate (WLCSPoS) During Component-Level and Board-Level Reliability Testing | Quality & Reliability | ACCEPT |
| 20 | Liu Chu, Jiajia Shi and Eduardo Souza de Cursi | An adaptive finite volume model (FVM) for heterogeneous interconnects in electronic packaging | Packaging Design & Modeling | accept? |
| 21 | Qiang Wei, Weidong Liu, Xiaojian Ma, Huan Yang, Jiachen Wang and Pengkai Wang | Simulation analysis and verification of warpage in reflow of large-size BGA product | Packaging Design & Modeling | ACCEPT |
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| 23 | Haodi Ren, Zhentao Yang, Fei Yu, Yongchao Chen and Linjie Liu | Research on the miniaturisation of the Ceramic Quad Flat Package (CQFP): Development of claw-shaped lead structure | Packaging Design & Modeling | ACCEPT |
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| 61 | Shuye Zhang, Guoli Sun, Binhao Qin, Haiyan Wang, Laifa Ding, Qingyang Qiu and Yupeng Zhang | A Novel Multiscale Homogenization Strategy for Large-Scale Glass Substrates | Quality & Reliability | ACCEPT |
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| 82 | Yuxuan Fan, Quanlu Zhao, Wenwen Zhang, Yunyan Zhou and Qidong Wang | Design and Verification of Fan-Out on Substrate Package Interconnects Based on UCle | Interconnection Technologies | ACCEPT |
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| 90 | Huilin Feng, Hui Liang, Yiming Luo, Gang Li, Pengli Zhu, Binbin Zhou and Rong Sun | Interface aging mechanism of SiO ₂ /EP in underfill investigated by in-situ Raman spectroscopy | Packaging Materials & Processes | ACCEPT |
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| 118 | Yida Lei, Jie Li and Wu Zhang | High-Performance Sr-Mn Co-Substituted BaM Ferrite for Microwave Applications | Packaging Materials & Processes | ACCEPT |
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| 130 | Dongmyeong Lee, Junyoung Choi, Suin Jang, Hoogwan Lee, Keiyu Komamura and Sarah Eunkyung Kim | Effect of Palladium Passivation via Electroplating and Electroless Plating on Low-Temperature Cu-to-Cu Bonding | Interconnection Technologies | accept? |

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| 153 | Hao Chen, Xin Zou, Zhirui Xu and Mingxiang Chen | Preparation and Process Optimization of High-Temperature Resistant Hermetic Multilayer Ceramic Substrate | Packaging Materials & Processes | ACCEPT |
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| 156 | Shaocheng Wu, Fei Lu, Jiazhe Zhang, Rongbin Xu, Yuhang Dou and Daquan Yu | The coupled BAW/SAW ScAlN resonator with high frequency and high electromechanical coupling coefficient. | MEMS, Sensors and IoT | ACCEPT |
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| 169 | Xiaojian Liu, Fang Yu, Ying Ding and Yuqing Zhang | Finite element simulation study of heat sink structure for integrated ceramic substrates | Packaging Design & Modeling | accept? |
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| 178 | Chien-Hung Yang, Fa-Chuan Chen, Wei-Tsung Tang, Chien-Min Lin, Che-Kuan Chu, Yu-Hsing Lin and Yin-Fa Chen | High-Precision X-ray Inspection of Flip Chip Packaging Leveraging Deep Learning and Instance Segmentation for Manufacturing Process Optimization | Quality & Reliability | ACCEPT |
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| 339 | Daoxiang Liu, Wenbin Chen, Kelaiti Xiao, Yu Zhang and Siqi Zhang | Chiplet In Metal | MEMS, Sensors and IoT | ACCEPT |
| 340 | Xiao Cui, Haotian Li, Yan Luo, Junwei Ma, Mifeng Liu, Lei Ding and Jiangbo Luo | Effects of coreless package substrate structure on signal integrity of chiplet interconnection | Interconnection Technologies | accept? |
| 341 | Lizhe Wang, Lili Yuan, Shiyong Yang and Haixia Yang | Photosensitive polyimides with adjustable taper angles | Packaging Materials & Processes | ACCEPT |

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| 342 | Li Liu, Haojie Ma, Yuan Yuan, Xianglong Jia and Zhiwen Chen | Molecular Dynamics Study of the Complexation Mechanism of Functional Groups with Copper Formate | Emerging Technologies | ACCEPT |
| 343 | Haitao Fu, Wei Yang, Wei Guo, Senlin Yang and Hongyan Tang | High density interconnections copper pillars fabrication | Packaging Materials & Processes | ACCEPT |
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| 346 | Jie Shen, Zhiyin Gan and Chenhao Zhang | Simulation and Experimental Study on Heat Transfer Distribution of MPCVD Sample Platform Surface | Advanced Manufacturing | ACCEPT |
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| 351 | Yanze Gao, Hanwen Cui, Xinlu Teng, Runting Niu, Yikang Zhou, Kai Zheng, Yuzheng Guo, Sheng Liu and Zhaofu Zhang | Numerical Study of a Novel Stacked Structure Trench Capacitor in 2.5D Packaging | Advanced Manufacturing | ACCEPT |
| 352 | Qufeng Li, Guisheng Gan, Ruidong Yan, Junfeng Dou, Fangliang Li, Junxiong Zhu, Daochun Xie, Daquan Xia and Xiangtao Xu | Effect Of Double-Side Cooling Packaging on the Properties of Dual-Base-Island Packaging | Packaging Materials & Processes | ACCEPT |
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| 357 | Jianlu Xue, Hongbin Xia, Shun Tik Yeung, Rolf Brenner and Tobias Sprogies | Study on the Influence of Si Wafer Plasma Dicing Parameters on Trench Sidewall Quality | Packaging Materials & Processes | ACCEPT |
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| 360 | Xinyuan Wang, Ruijie Liu, Haifa Qiu, Ben Tian, Deyi Chen, Yun Mou and Jianming Xu | Electro-Thermo-Mechanical Simulation Analysis of Al ₂ O ₃ , Si ₃ N ₄ and AlN substrates for high power chip modules by double-sided cooling | Packaging Design & Modeling | accept? |
| 361 | Lei Sun, Xuanyu Chen, Peng He and Shuye Zhang | Microstructure and properties of Sn58Bi solder reinforced by TiN nanoparticles | Packaging Materials & Processes | ACCEPT |
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| 367 | You Wang, Jian Zhang, Ming Zhao, Huijie Ye, Xiaomao Sun, Qian Lu and Chengju Liao | Analysis of Laser Ball Planting Process and Welding Strength Enhancement for 3D Heterogeneous SIP | Advanced Packaging | ACCEPT |
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| 370 | Qihang Zong, Chenshan Gao, Shizhen Li, Yihong Zhu and Huaiyu Ye | Mechanical Characterization of Sintered Ag Paste via Nanoindentation for Advanced Packaging in Power Electronics | Power Electronics | ACCEPT |
| 371 | Jinqian Huo, Yanfei Gong, Yuxin Wang and Liang Lou | Exploring low-temperature bonding of amorphous silicon thin films | MEMS, Sensors and IoT | ACCEPT |

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| 373 | Michael Dong, Linda Li and Tina Hu | Research of wafer Polyimide layer opening size guideline to support WB ball shear test | Packaging Design & Modeling | ACCEPT |
| 374 | Zhijie Zhang, Zhiqian Li, Ziting Jin and Chunjing Shi | Effect of Gelatin and MPS on the Electrodeposition of (111)-oriented Nanotwinned Copper | Packaging Materials & Processes | ACCEPT |
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| 377 | Xincheng Zhang, Na Liu, Bingxu Ma, Hang Liang, Haozhong Wang and Xiaofeng Yang | Thermal Failure Analysis and Reliability Optimization of Filter Chips | Quality & Reliability | ACCEPT |
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| 379 | Haowei Lu, Shineng Ma, Hao Luo, Xuwei Ding, Guangyao Li and Keqing Ouyang | AI-Driven Chip-Package-PCB Co-Design Method for FCBGA Package in Broadband Application | RF Electronic Packaging | accept? |
| 380 | Wenchao Wang, Hubing Wang, Delong Qiu and Chuan Chen | The Impact of Flow Conditions Control Method on Chip Thermal Dissipation in Immersion Liquid Cooling Systems | Emerging Technologies | ACCEPT |
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| 389 | Yuanyuan Yang, Ruoyu Zhang, Zihao Liu, Caiping Zhu, Gang Li, Pengli Zhu Zhu and Rong Sun | Research of toughener to flowability and reliability of Underfill in 2.5-D Packaging | Quality & Reliability | ACCEPT |

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| 390 | Deyu Lin and Yufang He | A Extreme Low Loss &Low CTE Build-up Resin Film For FCBGA | Packaging Materials & Processes | ACCEPT |
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| 392 | Zhihao Jiang, Liang Yang, Zihao Han, Tiqun Wei and Jianwei Dao | Ba ₃ SiO ₄ Br ₆ :Bi ³⁺ : A Broadband Cyan Phosphor for Full-Spectrum White Lighting | Optoelectronics and New Display | accept? |
| 393 | Hao Zeng, Haitao Fu and Xiaohong Yang | Lead-free hybrid manganese(II) halides nanoparticles as highly-efficient and stable β-ray scintillators | Optoelectronics and New Display | ACCEPT |
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| 397 | Yiping Wang, Zirui Tong, Peng Wu, Jiayun Feng, Shang Wang and Yanhong Tian | A Novel Liquid Metal Composite Ag ₂ Ga Nanoneedle Paste Enabling Low-Temperature Sintering and Enhanced Performance in Power Device Packaging | Emerging Technologies | ACCEPT |
| 398 | Ping Wu, Zhen Liu, You Qiu, Mingming Yi, Linzheng Fu, Lanying Xu, Wenhui Zhu and Liancheng Wang | Comparative Analysis of Substrate Equivalent Methods and Their Applications in Warpage Evaluation for Large Scale FCBGA Package | Packaging Design & Modeling | ACCEPT |
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| 401 | 溢杨, 博徐, 禹曹, 宝京朱, 滨韩, 玮陈, 坤何 and 衍行王 | Study on Microstructure and Performance Optimization of BaO– B ₂ O ₃ –SiO ₂ Glass-Ceramic/ZrO ₂ Composites | Packaging Materials & Processes | ACCEPT |
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| 404 | Haley Fu, Prabjit Singh, Raiyo Aspandier, Richard Coyle and Brian Franco | Some fundamentals of eutectic Sn-Bi and SAC305 solders metallurgy and electromigration | Packaging Materials & Processes | ACCEPT |
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| 421 | Xiaomao Sun, Chengju Liao, Qian Lu, Jian Zhang, Xin Kong, Wenhan Chang and You Wang | Study on Chipping Control in Laser Stealth Dicing Technology for GaAs Chips | Advanced Manufacturing | ACCEPT |
| 422 | Chunyu Lan, Gaowei Xu, Haijian Zhao, Yang Huang and Bojun Chen | Effect of Underfill on the Reliability of Indium Flip-Chip Interconnections Under Cryogenic Thermal Shock | MEMS, Sensors and IoT | ACCEPT |
| 423 | Yukai Xia, Haoran Ma, Zhou Gui, Tianhao Guo and Yiyang Cai | A Physics-Informed Convolutional Neural Network for Predicting Electromigration Lifetime in Copper Interconnects | Packaging Design & Modeling | accept? |
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| 435 | Junju Xu, Minglu Xia, Ziyang Gao, Chun Kit Cheung and Haihui Ruan | Investigation of Thermal Performance in Pin-fin Baseplate for High-Density SiC Power Modules | Power Electronics | ACCEPT |

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| 436 | Ziqi Lian, Yu Zhang, Fei Ding, Renxi Jin and Qidong Wang | Particles generation and mechanism analysis in plasma activation for direct D2W hybrid bonding | Advanced Packaging | ACCEPT |
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| 448 | Mingli Geng, Guisheng Gan, Jie Luo, Wenhao Luo, Ruizhe Xing, Yuhang Pan, Kai Qin and Qiao He | Effect of Cu nanoparticle addition on thermal reliability of Al/SAC0307+Zn/Cu joints | Quality & Reliability | ACCEPT |
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| 461 | Guanghua Yuan, Xianjun Kuang, Xingxian Xia, Xiaoling Lin, Xiaofeng Yang, Gaoming Shi, Weijian Zhou and Chao Li | Failure Mechanism of Electrochemical Migration Silver Electrode on Negative Temperature Coefficient Thermistor in Intelligent Power Module | Quality & Reliability | ACCEPT |
| 462 | Jianfang Zhu, Shikang Liu, Dongdong Shao and Kunpeng Ding | A Fan-Out Panel Level Packaging (FOPLP) Structure Achieving Double-Sided Die Bonding Interconnects Through Copper Through-mold Vias (TMVs) | Advanced Packaging | ACCEPT |
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| 470 | Mengke Yang, Qiuxi Li and Xiaowei Wang | Solution for solder joint reliability with radio energy efficiency features | Quality & Reliability | ACCEPT |
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| 474 | Bo Zhao and Jun Liu | Nano-TSV Fabrication for 3D Interconnection | Interconnection Technologies | ACCEPT |

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| 475 | Zihao Song, Danlei Wang, Kaixuan Nie, Zhe Li and Rong Sun | Regulating the end-group adsorption of levelers in redistribution layer copper electroplating for high-density advanced packaging | Packaging Materials & Processes | accept? |
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| 478 | Zhi Lin | The Morphology of Creep on Solder Joint under Different Condition of Temperature and Stress | Quality & Reliability | ACCEPT |
| 481 | Yuhan Gao, Yuxin Chen, Ziniu Yu, Yuqi Zhou, Kezhong Xu, Chuanjia Wang, Jianguo Xie and Fulong Zhu | In-situ Measurement Method for Warpage of Electronic Package Substrate Based on Speckle-free DIC and Carbon Coating | Advanced Manufacturing | ACCEPT |
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| 488 | Yuxin Ye, Ruiwen Liu, Peijie Li, Yanmei Kong, Guoran Lu, Xinhao Meng, Jingping Qiao, Jianliang Shen and Binbin Jiao | Silicon-based direct liquid cooling module for system on wafer | Advanced Packaging | ACCEPT |
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| 492 | Quanlu Zhao, Jingyi Zhao, Chuan Chen, Qidong Wang, Shanjun Ding and Xiaomeng Wu | Dicing Failure Mechanism and Structural Optimization for Large-Format Multilayer Glass Substrates | Quality & Reliability | ACCEPT |
| 493 | Yuxin Deng, Xiaodong Jian, Si Chen, Yu Zhao, Xiaofeng Yang, Nan Hua, Bin Zhou and Guoguang Lu | Effect of Defect Type on Structural Strength and Thermal Properties of Si/Ti, Ti/Au, Ti/Au, and Au/Au Interfaces | Quality & Reliability | ACCEPT |
| 494 | Jianming Fang, Chengwei Zhang and Zihao Liu | Study On Failures Of Silver Bonding Wire In Real-World Applications | Quality & Reliability | ACCEPT |

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| 495 | Feng Zhu, Yangming Liu, Bo Yang and Ning Ye | ELK Stress Simulation and Parameter Optimization Design in Flip Chip Packaging | Packaging Design & Modeling | accept? |
| 496 | Haojie Zhou, Boyan Zhao, Min Wu, Guoxu Fang, Xiaoxiao Ji, Luqiao Yin and Jianhua Zhang | Micro-LED Array with 370×110 Resolution for Digital Headlights | Optoelectronics and New Display | ACCEPT |
| 497 | Zhijun Long, Chenxi Yang, Jianguo Zhang, Bin Yu, Guanghao Zeng, Zhen Zhang, Guangyao Li and Keqing Ouyang | The Simulation and Testing of UCle Power Noise Based on Chiplet | Packaging Design & Modeling | ACCEPT |
| 498 | Wanbin Yang, Hao Yang, Sha Xu, Chunbing Guo and Fa Dai | Thermal Reliability Analysis and Optimization of Millimeter-Wave Multi-Chip RF Front-End Modules under High-Density Packaging | Quality & Reliability | ACCEPT |
| 499 | Meiyu Wang, Zhuo Pang, Yiting Han and Zewei Zhang | Stress Relief of Power Module Using Sintered-Silver Die Attachment in Cylinder-Grid-Array (CGA) | Packaging Design & Modeling | ACCEPT |
| 500 | Jinzhu Li, Qichun Lou, Ziyu Liu, Mingze Ban, Zeyu Ning, Chuandong Li and Qingqing Sun | Measurement and improvement of PI surface energy applied for novel PI-Cu hybrid bonding | Interconnection Technologies | ACCEPT |
| 501 | Zhen Sun, Xin-Ping Zhang, Jia-Ao Chen, Ming-Sheng Luo and Guang-Chao Lyu | The Interfacial Delamination and Fracture Behavior of Cu-filled TGV Interposer Package with Multi-Layer RDLs under Thermo-mechanical Loads | Quality & Reliability | ACCEPT |
| 502 | Bowen Cai, Zhong Lian, Qi Zhang, Zhi-Quan Liu and Changyou Ren | Investigation on the interfacial behavior and interconnection reliability of adhesion layer for gold-silver wire bonding | Advanced Manufacturing | ACCEPT |
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| 505 | Yanchen Li, Ruichong Li, Li-Yin Gao and Zhi-Quan Liu | Study on the oxidation mechanism of electroplated copper with different grain orientations | Packaging Materials & Processes | ACCEPT |
| 506 | Haokang Zhang, Dekun Yang and Lingjie Li | Design of LSPR optical memory based on angle-resolved scattering measurement | Optoelectronics and New Display | ACCEPT |
| 507 | Lingjie Li, Dekun Yang and Haokang Zhang | Deep Learning Based Angle-Resolved Critical Dimension Metrology for 3D NAND Channel Hole Structures | Optoelectronics and New Display | ACCEPT |
| 508 | Yichi Pan and Dekun Yang | TSV Measurements Of Angle-Resolved Scattering | Optoelectronics and New Display | ACCEPT |
| 509 | Zijun Luo, Ke Zhang, Liang He, Zhiyuan He, Yijun Shi, Xinghuan Chen and Yuan Chen | Performance Degradation of the Schottky p-gate GaN HEMT Under Power Cycling | Quality & Reliability | ACCEPT |

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| 510 | Yunting Zhu, Yicheng You, Hailang Wen, Ke Li, Xueer Chen, Weiyi Lin and Daquan Yu | Assembly of diamond microstructures in 3D package system for efficient thermal dissipation | Emerging Technologies | ACCEPT |
| 511 | Qian Zhou, Guangjun Lu, Hongqing Wei, Jiande Su and Jia Nie | Fabrication of blue perovskite light-emitting devices based on planar printing technology | Optoelectronics and New Display | accept? |
| 512 | Feng Xie, Shouliang Hu, Yuefang Li, Hu Chen and Wei Zhong | Investigation on the brazing interface failure assessment of SiP ceramic envelope under multi-axial stress | Quality & Reliability | ACCEPT |
| 513 | Yonglin Xia, Yufei Sheng, Jiaxuan Xu and Hua Bao | Phonon Boltzmann Transport Equation-Based Thermal Simulation and Effective Thermal Conductivity Extraction of FEOL for 3D Advanced Packaging Thermal Management | Packaging Design & Modeling | ACCEPT |
| 514 | Ru Jia, Xinyu Zhang, Yufei Sheng and Hua Bao | Analysis of Self-Heating Effects in Cryo-CMOS technology Modeled by Phonon Boltzmann Transport Equation | Packaging Design & Modeling | accept? |
| 515 | Genghua Zhang, Fangyuan Zeng, Qi Zhang and Zhiquan Liu | The effects of additives on impurities, microstructure, and reliability of copper coatings | Packaging Materials & Processes | ACCEPT |
| 516 | Xin-Ping Zhang, Jia-Wei Deng, Ming-Sheng Luo, Can Zhao, Pu Xu, Si-Yuan Wang and Ming-Bo Zhou | Reducing Splashing and Residual Defects in Laser Soldering: Optimization of Process Parameters and Development of a adapted Solder Paste | Packaging Materials & Processes | ACCEPT |
| 517 | Yonggui Chen, Zhengwei Fan, Kaihong Hou, Shufeng Zhang, Yashun Wang and Xun Chen | The effect of different copper defect shapes on the behavior of TSV under thermal cycling | Quality & Reliability | ACCEPT |
| 518 | Xin Chen, Jingyu Lin and Daquan Yu | Low-loss Substrate Integrated Waveguide Bandpass Filter Based on Through Glass Via for Millimeter Wave Application | Advanced Packaging | ACCEPT |
| 519 | Kuiyu Xiao, Lianqiao Yang and Ming Li | Multi-physics coupling analysis of hybrid bonding based on finite element analysis | Interconnection Technologies | accept? |
| 523 | Jiahao Yin, Nan Huang, Lanyu Zhang and Jian Gao | Development and test of a high precision walker-type inchworm piezoelectric motor | Advanced Manufacturing | ACCEPT |
| 524 | Jian-Wei Xian, Xin-Ping Zhang, Hai-Ping Li, Hui-Qian Zhou and Xiao Ma | A Novel Large-Area Photoresist Removal Process for Multi-wafer in Advanced Packaging by Surface Wave Plasma | Advanced Manufacturing | ACCEPT |
| 525 | Zhiyu He, Zheyao Wang and Kai Zheng | Finite Element Analysis of the Impact of Copper Density on Hybrid Bonding Interfacial Stress | Packaging Design & Modeling | ACCEPT |
| 526 | Daquan Yu, Zhan Meng and Xuesong Quan | Copper Filling of Taper-Free High-Aspect-Ratio Diamond Through Holes for Fabricating Integrated Passive Components | Interconnection Technologies | ACCEPT |

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| 527 | Jianming Fang, Jinzhou Li and Xinbin Guan | Failure Analysis of Bonding Crater Damage in Gold, Copper, and Silver Wire | Quality & Reliability | ACCEPT |
| 528 | Hongqing Wei, Guangjun Lu, Qian Zhou, Jiande Su and Jia Nie | Introducing a synergistic strategy of multifunctional small molecules and gradient optimization of hole transport layer to prepare efficient and stable blue perovskite LEDs with high efficiency | Optoelectronics and New Display | accept? |
| 529 | Zhiqiang Huang, Lingfeng Deng, Min Wang, Jianxiong Liu and Xuanlong Chen | Failure Analysis of RF Switches Combining FIB Circuit Modification and OBIRCH Localization | Quality & Reliability | ACCEPT |
| 530 | Haikun Yue, Wenbo Luo and Yang Tang | A W-band Phased Array Antenna-in-Package (AiP) Based on Glass Substrate | Advanced Packaging | ACCEPT |
| 531 | Chen Lijun, Feng Chen and Fengwei Dai | Thickness controllable 3D NAND flash package with wafer-level fan-out packaging | Advanced Packaging | ACCEPT |
| 532 | Chen Ma, Xudong Xu, Xi He, Zhiyu Wang, Feixuan Huang, Lihang Liao and Nan Wang | Coupling Coefficient Enhancement Achieved by Floating Electrodes on AlN Thin Film Resonators | RF Electronic Packaging | ACCEPT |
| 533 | Ying Tian, Shiyuan Wang, Daquan Yu, Li Yan, Miao Zhang and Meng Wei | Application Research on Chip Bonding Technology for Highly Integrated SiP Devices | Emerging Technologies | ACCEPT |
| 534 | Bie Xiaorui, Zheng Wang, Kunfeng Wang, Wuhao Yang, Zhitian Li and Xudong Zou | Analysis of thermal hysteresis in silicon resonant accelerometers caused by packaging stress | MEMS, Sensors and IoT | ACCEPT |
| 535 | Xuetao Yan, Xiangxu Meng, Siwei Sun, Yetong Zhang, Fengman Liu and Qidong Wang | Modeling and Optimization of Nonlinearity in PIN-Type Position Sensitive Detectors: A Combined Theoretical and Numerical Approach | Optoelectronics and New Display | accept? |
| 536 | Xing Zhou, Yuxin Ye, Yanmei Kong, Ruiwen Liu, Binbin Jiao, Zihang Yuan, Shuxiang Wang, Xinhao Meng and Zilong Wang | Embedded Microfluidic cooling for System on wafer: thermal design and CFD simulation | Advanced Packaging | ACCEPT |
| 537 | Zihang Yuan, Yuxin Ye, Yanmei Kong, Ruiwen Liu, Binbin Jiao, Xing Zhou, Shuxiang Wang, Guoran Lu and Ruihai Su | The study of embedded microfluidic cooling for chip thermal management at KW/cm ² level | Advanced Packaging | ACCEPT |
| 538 | Hai Huang, Quanlu Zhao, Chuan Chen, Meiyong Su, Rong Fu and Jun Li | Active Thermal Management Strategy and Mathematical Modeling for System-Level Packaged Modules in Logging-While-Drilling Systems | Packaging Design & Modeling | ACCEPT |
| 539 | Dou Xu, Gaohui Xu, Xinyi Shi, Yujian Wang and Wanli Li | Low-Temperature Copper Sintering Bonding Technology Based on Non-Spherical Bimodal Design and Solvent Optimization | Packaging Materials & Processes | ACCEPT |
| 540 | Donglin Cao, Kechen Zhao, Xiaoyu Guan, Chufei Cheng, Jiwen Zhao, Bing Dai and Jiaqi Zhu | High-temperature resistant wafer-level temporary bonding by W release layer for diamond growth | Packaging Materials & Processes | ACCEPT |

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| 541 | Zikang Luo, Xiuqi Wang, Jingyuan Ma, Yifan Li, Pengjie Zhou and Hongjun Ji | Ultrasonic-assisted wetting behaviors of Sn solder on (111) nano-twinned Cu electroplating films for UBM | Packaging Materials & Processes | ACCEPT |
| 542 | Jiahao Yu, Pingjuan Niu, Pingfan Ning and Jie Liu | Reliability Analysis and Lifetime Prediction of Low-Inductance Double-Sided Cooling SiC Power Modules | Quality & Reliability | ACCEPT |
| 543 | Yuqiang Zhang, Haiyun Xue, Yu Zhang, Fengman Liu and Qidong Wang | Etch-Free Lithium Niobate Electro-Optic Modulator with 110 GHz Bandwidth: Simulation Design and Performance Optimization | Optoelectronics and New Display | ACCEPT |
| 544 | Yifan Li, Xiuqi Wang, Zikang Luo, Mingyu Li and Hongjun Ji | Direct low-temperature sintering of Cu nanoparticles on laser-metallized AlN ceramics by UV nanosecond laser | Packaging Materials & Processes | ACCEPT |
| 545 | Lai Wei and Guoqi Zhang | Metallic Sintering Interconnect using on-substrate microheater | Optoelectronics and New Display | accept? |
| 547 | Hao Guan, Yifei Chang and Pan Liu | Simulation, Verification, and Failure Analysis of 1.2kV Planar-Gate SiC MOSFET Under Surge Current Stress of Body Diode | Power Electronics | ACCEPT |
| 548 | Kexuan Zhang, Yang Qiu, Xingyan Zhao, Shaonan Zheng, Yuan Dong, Qize Zhong and Ting Hu | A Concave-Convex Cu Interconnect Pair Structure for Cu-Cu Direct Bonding with Self-alignment Capability and Enhanced Shear Strength | Packaging Design & Modeling | accept? |
| 549 | Xiuqi Wang, Pengjie Zhou, Dashi Lu, Mingyu Li and Hongjun Ji | CuAgSnIn nanoparticle composite joints with rapid bonding and high shear strength for power electronics packaging | Power Electronics | ACCEPT |
| 550 | Gong Mingjie, Huang Dong and Shi Hailin | Research on advanced manufacturing mode of high reliability hybrid integrated circuit | Advanced Manufacturing | ACCEPT |
| 551 | Guoqiang Zhao and Yi Zhao | Finite Element Modeling of the Effects of Copper Density on Bonding Strength and Interfacial Stress in 1 μ m Pitch Hybrid Bonding | Interconnection Technologies | accept? |
| 552 | Zhixin Sheng, Rui Cao, Huimin He, Bowen Zhou, Xianpeng Chen, Haiyun Xue, Fengman Liu and Qidong Wang | Research on high-density and high-efficiency optical coupling packaging of 100 Gbps vertical cavity laser emitter array for CPO | Optoelectronics and New Display | ACCEPT |
| 553 | Bowen Zhou, Rui Cao, Huimin He, Zhixin Sheng, Xianpeng Chen, Haiyun Xue, Fengman Liu and Qidong Wang | Skin Depth Considerations: How Copper Roughness Degrades Differential Signal Propagation Above 100Gbps | Optoelectronics and New Display | ACCEPT |
| 554 | Hao Wang, Lihang Liao, Chen Ma, Xudong Xu, Ziyi Ge, Xitong Wang, Renzhe Li, Lekang Lin, Zhiyu Wang and Nan Wang | Design of Wideband Hybrid Bandpass Filter with Steep Roll-off and High Out-of-band Rejection | RF Electronic Packaging | ACCEPT |
| 555 | Ziyi Ge, Chen Ma, Xudong Xu, Hao Wang, Lekang Lin, Renzhe Li and Nan Wang | Investigation on High Power Durability FBAR Devices | RF Electronic Packaging | ACCEPT |

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| 556 | Jingsheng Liu, Baojun Qiu and Hui Tang | The Component Level Reliability Verification of An Automotive Grade Microcontroller | Quality & Reliability | ACCEPT |
| 557 | Kefu Zeng, Zehua Tang, Guannan Yang, Yu Zhang, Guanghan Huang and Chengqiang Cui | Surface metallization of glass substrate through an interlayer of glass-copper composite | Advanced Manufacturing | ACCEPT |
| 558 | Junxiong Zhu, Guisheng Gan, Junfeng Dou, Fangliang Li, Qufeng Li, Daochun Xie, Rongyu Chen, Daquan Xia and Xiangtao Xu | Effect of Nano-SAC0307 Content on Performance of Cu/Al Joints with Dual-Ultrasonic Synergism at Low Temperature | Packaging Materials & Processes | ACCEPT |
| 559 | Guandong Liu | Advanced Packaging-Compatible Vertical Micro-Lenses for Micro-Opto-Electro-Mechanical Systems | Optoelectronics and New Display | ACCEPT |
| 560 | You Zhi, Wang Linggen, Mu Wei, Tian Tiancheng, Wang Han, Chen Fengwen and Wang Yihao | stress analysis of power module during pressure sintering process | Power Electronics | accept? |
| 561 | Peng Sun, Yi Zhong and Daquan Yu | One-Step Electroless Copper Plating Enabled by Self-Assembled Silane Monolayers on Glass Substrate Surfaces | Emerging Technologies | ACCEPT |
| 562 | Xianpeng Chen, Rui Cao, Huimin He, Zhixin Sheng, Bowen Zhou, Fengman Liu and Qidong Wang | Impact of TSV Annealing Thermal Stress on Micro-Ring Modulator in 3D optical IO | Optoelectronics and New Display | ACCEPT |
| 563 | Zhiying Yu, Lingfeng Deng, Jianxiong Liu, Min Wang, Zhiqiang Huang and Xinbin Guan | An Innovative Failure Localization Method for Multi-layer Stacked Metal Capacitors in Integrated Circuits: Layer Thinning Combined with OBIRCH Technique | Quality & Reliability | ACCEPT |
| 565 | Gen Li | An Asymmetrically Interlocked Ultra-wide Sensing Range Capacitive Tactile Sensor With A Two-stage Enhancement Pyramid Microstructural | MEMS, Sensors and IoT | ACCEPT |
| 566 | Hailang Wen, Yunting Zhu, Yicheng You, Weiyi Lin and Daquan Yu | Large-Scale Interconnection for High-Power Diamond Radio Frequency Devices | Emerging Technologies | ACCEPT |
| 567 | Kewei Wu and Deyin Zheng | Enhancing Two-Phase Immersion Cooling for High-Power Chips through Integrated Vapor Chamber | Packaging Design & Modeling | ACCEPT |
| 568 | Zijun Luo, Shuqiang Liu, Xia Luo, Wannan Zhan, Jinbao Cai, Zhiyuan He, Yuan Chen and Liang He | Degradation Analysis of SiC MOSFETs Under High Temperature Gate Bias Stress Above 200°C | Quality & Reliability | ACCEPT |
| 569 | Hai-Ping Li, Xin-Ping Zhang, Jian-Wei Xian, Hui-Qian Zhou and Min-Bo Zhou | Process Optimization and Mechanism of Photoresist Removal using Remote Plasma in High-Aspect-Ratio Structures for Advanced Packaging | Advanced Manufacturing | ACCEPT |
| 570 | Xudong Xu, Chen Ma, Jiwei Jiang, Ziyi Ge, Zhiyu Wang, Feixuan Huang, Renzhe Li, Hao Wang, Lekang Lin, Chunmiao Qi and Nan Wang | Interdigital-shape Phononic crystal for the improvement of quality factor based piezoelectric-on-silicon MEMS resonators | RF Electronic Packaging | ACCEPT |

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| 572 | Wang Chongyue, Guo Jianheng, Chen Biqu, Lin Renyi and Li Zongtao | Frequency-Division Multiplexed Quantum Dot-Polymer Optical Fiber Sensor for Distributed Gesture Recognition | Optoelectronics and New Display | accept? |
| 573 | Yue Tang, Huanpeng Wang, Kun He, Jie Liu, Musheng Liang and Yuehang Xu | Research on the Analysis of Fracture Failure Mechanisms in Heterogeneous Integration Interconnect Structures under Thermoelectric Coupling. | Quality & Reliability | ACCEPT |
| 574 | Shaodian Yang, Zheng Chen, Zhiqiang Lin, Zhengxun Hu and Rong Sun | Investigation of Wafer Warpage and Chip Misalignment in Advanced Packaging: Material-Process Interactions in wafer reconstruction techniques | Packaging Design & Modeling | accept? |
| 575 | Xinyi Wang, Youxing Zhang, Zhaoyu Chen, Haojie Zhou, Xiaoxiao Ji, Luqiao Yin and Jianhua Zhang | Dual Wettability Control of Coffee Ring Effect in QDCC Layer with BM | Optoelectronics and New Display | ACCEPT |
| 576 | Zhu Yang, Xiaoxiao Ji, Haojie Zhou, Guoxu Fang, Min Wu, Luqiao Yin, Xiuzhen Lu and Jianhua Zhang | Preparation of Blue GaN Micro-LED Array Based on Direct Laser Transfer and Thermocompression Bonding Process | Optoelectronics and New Display | ACCEPT |
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| 578 | Ruiting Zhang, Zhiqiang Lin, Zhengxun Hu and Rong Sun | The Impact and Application of Hydrophilicity of Wafer Surface on Defect Removal Efficiency after CMP | Advanced Packaging | ACCEPT |
| 579 | Wen-Long Shao, Lin-Jie Liu, Zhen-Tao Yang, Xi-Meng Yu and Run-Zhang Wang | Design of a wideband Package for MMIC Applications Based on High Temperature Co-fired Ceramic | RF Electronic Packaging | accept? |
| 580 | Qiang Ping, Lei Yang, Lei Qiu, Jianwei Zong and Liang Lou | A NOVEL CANTILEVER-BASED MINIATURIZED PIEZOELECTRIC HYDROPHONE | MEMS, Sensors and IoT | ACCEPT |
| 581 | Ziyan Zhou, Lei Li, Qinsong Qian and Weifeng Sun | Optimized Design of 48-1V LLC-DCX Transformer Structure Based on Finite Element Analysis Achieving 1900W/in ³ Power Density | Power Electronics | ACCEPT |
| 583 | Chen Peng, Fengze Hou, Rui Ma, Meiyang Su, Yunyan Zhou, Qidong Wang, Zijun Zhong and Liqiang Cao | Warpage Analysis of RDL-First Fan-Out Packaging Using Solid-Shell Element and Reduced-Order Models | Packaging Design & Modeling | ACCEPT |
| 585 | Le Chen, Yu Zhang, Yuting Zhang, Yanzhe Xu and Qiang Ma | KSF/ β -Sialon Phosphor System Innovations in Mini-LED Backlight Technology | Optoelectronics and New Display | ACCEPT |
| 587 | Jiawen Wen, Wenli Zhang, Zhan Wang, Zewen Li and Guan hong Yu | Parasitic Parameter Extraction and Wire-Bonding Optimization for Cascode GaN FET in A New TO-247-4L Package | Power Electronics | ACCEPT |
| 588 | Jun Xiao, Run Shao, Wenguo Ning, Jing Wang and Yongchao Fu | Failure Analysis and Improvement of b-HAST for eMMC Products | Quality & Reliability | ACCEPT |

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| 589 | Xuwei Zhao, Ruiyang Zhou, Yilin Ma, Yanqiang Yang, Yang Pang and Fanchen Meng | Thermal Reliability Study of TSV Structures for Flip-Chip MEMS Inertial Devices | Quality & Reliability | ACCEPT |
| 590 | Shengnan Li, Yafei Wang and Hong Li | High-Performance Epoxy Molding Compound Localization: Technological Breakthrough and Industrial Validation for Semiconductor Supply Chain Autonomy | Quality & Reliability | ACCEPT |
| 593 | Zhen-Tao Yang | Research on a High Reliability CQFN Package with a Pitch of 0.50 mm at 50 GHz | RF Electronic Packaging | accept? |
| 597 | Qingxin Liu, Kailin Ren, Luqiao Yin and Jianhua Zhang | Monolithically Integrated Voltage Reference Based on p-GaN/AlGaIn/GaN Heterostructure | Power Electronics | ACCEPT |
| 599 | Qiunan Shi, Junjie Li, Kaihou Wang, Yatian Tang, Zhengbiao Zhang and Guoliang Xie | Wafer-level TSV package of TF-SAW filter built by low-stress silicon-cap epoxy bonding | Advanced Packaging | ACCEPT |
| 600 | Hengtong Guo Hengtong, Shimeng Xu, Xiaochen Xie, Pengrong Lin, Jianzhong Li and Changhao Chen | Research on High Reliability Copper Pillar Micro Convex Interconnection Technology for Aerospace Chip Integration | Interconnection Technologies | ACCEPT |
| 601 | Patrik Carazzetti, Carl Drechsel, Jürgen Weichart, Kay Viehweger and Ewald Strolz | Development of a Highly Sensitive Test Vehicle for the Accurate Measurement of Seed Layer Contact Resistance in 2.0 μm -diameter Vias | Advanced Packaging | ACCEPT |
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| 603 | Yuchen Wei, Leyin Zhang, Susu Li, Han Jiang, Zhihong Zhong, Yaohua Xu and Shuibao Liang | Unraveling Grain Boundary Migration and Evolution of the Cu-Cu bonding Structure Driven by Thermo-mechanical Stress | Interconnection Technologies | ACCEPT |
| 604 | Hao Zhang, Xing Jin, Bin Wang, Jian Xiang, Jian Wang, Rui Tang and Xiaoqiang Wang | Degradation Mechanism Induced by High-Energy Hot Electrons in GaN MMIC Power Amplifiers under High Drain Bias Stress | Quality & Reliability | ACCEPT |
| 606 | Hao Fu, Zhu Yang, Hong Fan, Xinhui Meng, Xiuzhen Lu, Luqiao Yin and Jianhua Zhang | Simulation and Experimental Validation of Bonding Between Copper Pillar Bumps and Micro-LED | Optoelectronics and New Display | ACCEPT |
| 607 | Lianyu Wang, Kailin Ren, Luqiao Yin and Jianhua Zhang | Study of Cu/Al ₂ O ₃ hybrid bonding process based on atomic layer etching | Advanced Packaging | ACCEPT |
| 609 | Lixiang Zhang and Xuejiao Zhang | The influence of vacancy defects on the interface thermal resistance of diamond based GaN RF device | Emerging Technologies | ACCEPT |
| 611 | Renzhe Li, Feixuan Huang, Chen Ma, Feiya Suo, Xudong Xu, Ziyi Ge, Xitong Wang and Nan Wang | Spurious Mode Suppression of Thin-Film Lithium Niobate A3 Mode Lamb Wave Resonators | RF Electronic Packaging | ACCEPT |

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| 612 | Xuwei Zhao, Nannan Li, Zhiqiang Gao, Deyan Wang, Xiao Ma and Zihan Nan | Failure Mechanism of the Si-TSV Structure Under Temperature and Radiation Synergistic Effects | Quality & Reliability | ACCEPT |
| 613 | Huan Liu, Zhijun Lv, He Jiang and Fei Wang | Development of High-performance Silicon-based MEMS Bandpass Filter | RF Electronic Packaging | ACCEPT |
| 614 | Haoran Ma, Min Gou, Xinxu Zhang, Shiyu Chen and Meng Sun | Simulation and Design of the 3D Silicon Capacitor Structure Charactered by Low-Parasitic, High-Capacitance and High-Reliability | RF Electronic Packaging | ACCEPT |
| 615 | Jinyang Zhao, Lixin Zhan, Xinpeng Chen, Yaru Zhang and Baoxia Li | Void Defect Analysis and Mitigation in Underfill Process of PoP Flip-Chip Packages: A Multiphysics Modeling and Experimental Investigation | Advanced Packaging | ACCEPT |
| 616 | Xiaoyue Duan, Panpan Jiang, Liang He, Yijun Shi, Xinghuan Chen, Zhiyuan He, Yuan Chen and Yiqiang Ni | Hydrogen effects on enhanced-mode AlGaIn/GaN MOSFET with Al ₂ O ₃ gate dielectric | Quality & Reliability | ACCEPT |
| 617 | Yufei Bai, Xiaoyun Qi, Jia Yang and Chenxi Wang | A Novel NH ₄ OH-assisted Self-Aligned Cu/SiO ₂ Bonding for High-Precision and High-Speed Hybrid Bonding. | Interconnection Technologies | ACCEPT |
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| 619 | Liangxing Hu, Huaiyun Fan, Xin Zhang, Yongfa Dong, Yaobin Li, Hesheng Tan, Yaqing Li, Huabing Deng, Yanyun Zhang, Nan Wang and Kai Tao | Time-Dependent Evolution Study of Plasma-Treated Al Surface Enabling Two-Step Al-Al Direct Bonding in Ambient | Interconnection Technologies | ACCEPT |
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| 622 | Lin Daotan, Wu Huiwei and He Guanghui | Research on Construction Analysis Method of 3D Stacked Chips Based on Failure Mechanism | Quality & Reliability | ACCEPT |
| 623 | Xinpeng Chen, Yaru Zhang, Lixin Zhan, Jinyang Zhao and Baoxia Li | Research on 3D Assembly Process Based on Wafer-Level Electroplated Microbump Structures | Advanced Packaging | ACCEPT |
| 624 | Qian Zhou, Donghua Yang, Jun Luo, Bin Jiang, Zhenhua Wang, Chunhong Zhang and Kailun Hu | Multicomponent Alloy Design and Performance Optimization of Sn-In-Ag-Al-Zn Solder alloys | Packaging Materials & Processes | ACCEPT |
| 625 | Yuting Liang, Junpeng Fang, Qian Wang, Jian Cai, Yao Zheng, Haiyan Ma and Yalu Chen | Structural Evolution of Chip to Chip Hybrid Bonding Interface after Temperature Cycling and High Temperature Storage Tests | Interconnection Technologies | ACCEPT |

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| 626 | Longsheng Fang, Wei Shen, Mengyun Zhang, Shimiao Wang and Tao Hang | Texture Modulated Cobalt Film with Improved Soft Magnetic Properties for Low-loss High-frequency Signal Transmission | Packaging Materials & Processes | ACCEPT |
| 627 | Wei Zhang and Liang Ren | Active Thermography for Quantitative Assessment of Solder Fill Height in Through-Hole Interconnects: A Coupled Numerical-Experimental Investigation | Packaging Design & Modeling | ACCEPT |
| 628 | Yik Fan Chen, Zirou Chen and Jun Wang | Influence of Underfill and EMC Material Properties on Bump Thermal Stress in 2.5D CoWoS Structure | Packaging Materials & Processes | ACCEPT |
| 629 | Xu Han, Fang Dong, Chengliang Sun and Sheng Liu | A high uniform electric field in drift region with array structure 4H-SiC LDMOS | Power Electronics | accept? |
| 630 | Sichen Liang, Zhiheng Huang, Kaiwen Zheng, Min Xiao, Yuezhong Meng and Yang Liu | Microstructural Hierarchy Data Insights from Ag Paste and Cu-Cu Hybrid Bonding | Interconnection Technologies | ACCEPT |
| 631 | Yuke Jin, Zhu Yang, Xinhui Meng, Hao Fu, Luqiao Yin, Xiuzhen Lu and Jianhua Zhang | Thermo-Mechanical Coupling Simulation of Laser-Based Mass Transfer for Micro-LEDs | Optoelectronics and New Display | ACCEPT |
| 634 | Feiya Suo, Feixuan Huang, Chen Ma, Renzhe Li and Nan Wang | Spurious Mode Suppression in Lamb Wave MEMS Resonators Based on 128°Y-Cut LiNbO3/SiO2 | RF Electronic Packaging | ACCEPT |
| 636 | Xitong Wang, Jiwei Jiang, Chen Ma, Zhiyu Wang, Feixuan Huang, Renzhe Li, Ziyi Ge, Chunmiao Qi and Nan Wang | High-Coupling and Lithographic Frequency Tunable Solidly Mounted Resonator (SMR) with Alternating Polarity-Inverted Piezoelectric Layer | RF Electronic Packaging | ACCEPT |
| 637 | Bofu Li, Baorong Su, Shunfeng Han and Miao Cai | WBLGA SiP High-Reliability and High-Thermal Conductivity Design Optimization and Interconnect Process Exploration | Optoelectronics and New Display | ACCEPT |
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